Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/695,908	LEE, YUN-BOK
Examiner	Art Unit
Richard H. Kim	2871

	SEARCHED					
Class	Subclass	Date	Examiner			
349	141-146	4/14/2005	RHK			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
	<u> </u>	<u> </u>		

(INCLUDING SEAR		
	DATE	EXMR
East Search	4/14/2005	RHK